Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/808,275	FESSOU ET AL.
Examiner	Art Unit
Devin Hanan	3745

	SEARCHED				
Class	Subclass	Date	Examiner		
415	191-192				
	211.2				
	208.1		·		
	208.2				
	210.1	,			
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INT	ITERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
consulted Ninh Nguyen on class 415 and 416	8/24/2005	DH		
consulted Chris Verdier on class 415 and 416	8/30/2005	DH		
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